



High Speed CMOS Synchronous Presettable 4-Bit Binary Counters

QS54/74FCT161T
QS54/74FCT163T

QS54/74FCT2161T
QS54/74FCT2163T

FEATURES/BENEFITS

- Pin and function compatible to the 74F161/3 74FCT161/3 and 74FCT161T/3T
- CMOS power levels: <7.5 mW static
- Available in DIP, SOIC, QSOP, ZIP, HQSOP
- Undershoot clamp diodes on all inputs
- TTL-compatible input and output levels
- Ground bounce controlled outputs
- Reduced output swing of 0-3.5V
- Military product compliant to MIL-STD-883

FCT-T 161T, 163T

- JEDEC-FCT spec compatible
- Fastest CMOS logic family available
- Std. thru C speed grades with 5.6 ns t_{PD} for C
- I_{OL} = 48 mA Com., 32 mA Mil.

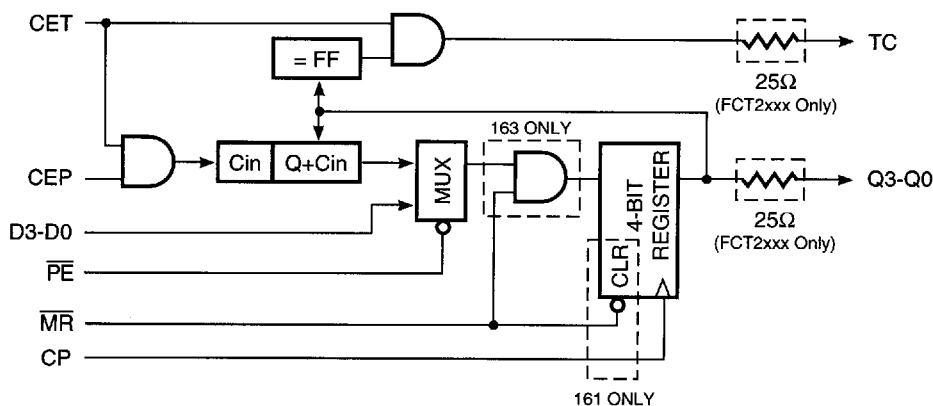
FCT-T 2161T, 2163T

- Built-in 25Ω series resistor outputs reduce reflection and other system noise
- Std. and A speed grades with 6.2 ns t_{PD} for A
- I_{OL} = 12 mA Com.

DESCRIPTION

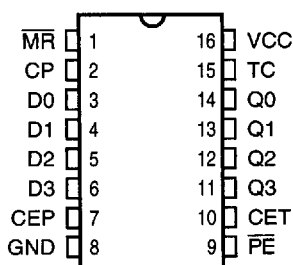
The QSFC161T and QSFC163T are high-speed CMOS synchronous presettable 4-bit binary counters. The 161 has an asynchronous clear; the 163 has a clocked synchronous clear. The 2161 and 2163 are 25Ω resistor output versions of the 161 and 163, respectively, and are useful for driving transmission lines and reducing system noise. Data is preloaded or the counters count on the rising edge of the clock. Count enable inputs and terminal count outputs allow these counters to be cascaded without loss of speed. Preset inputs override count inputs, and clear inputs override both preset and count inputs. All inputs have clamp diodes for undershoot noise suppression. All outputs have ground bounce suppression (see QSI Application Note AN-001).

FUNCTIONAL BLOCK DIAGRAM

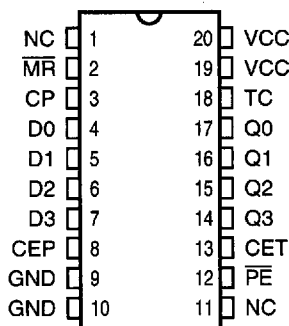


PIN CONFIGURATIONS (All Pins Top View)

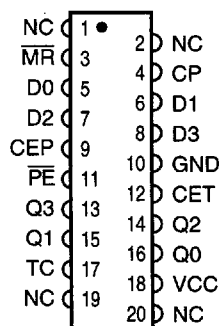
PDIP, SOIC, QSOP



HQSOP



ZIP



Note:

Available in both 150 mil wide SOIC (package code S1) and 300 mil SOIC (package code SO).

PIN DESCRIPTION

Name	I/O	Description
D3-D0	I	Data Inputs
Q3-Q0	O	Data Outputs
CP	I	Clock
MR	I	Master Reset

Name	I/O	Description
CEP	I	Count Enable
CET	I	Count and TC Enable
TC	O	Terminal Count
PE	I	Parallel Load Enable

FUNCTION TABLE

Inputs						Ouputs			Function
MR	PE	CP	CEP	CET	DI	Q3-Q0		TC	
						161	163		
L	X	X	X	X	X	L	—	L	Clear 161
L	X	↑	X	X	X	—	L	L	Clear 163
H	L	↑	X	X	D3-D0	D3-D0	D3-D0	X	Load Data
H	H	↑	H	H	X	Q+1	Q+1	X	Count
H	H	↑	L	X	X	Q	Q	X	Count Inhibit P
H	H	↑	X	L	X	Q	Q	X	Count Inhibit T
H	H	X	X	H	X	F	F	H	Count = 1111
H	H	X	X	H	X	0-E	0-E	L	Count ≠ 1111
H	H	X	X	L	X	X	X	L	TC Inhibit

ABSOLUTE MAXIMUM RATINGS

Supply Voltage to Ground	-0.5V to +7.0V
DC Output Voltage V_{OUT}	-0.5V to +7.0V
DC Input Voltage V_{IN}	-0.5V to +7.0V
AC Input Voltage (for a pulse width ≤ 20 ns)	-3.0V
DC Input Diode Current with $V_{IN} < 0$	-20 mA
DC Output Diode Current with $V_{OUT} < 0$	-50 mA
DC Output Current Max. Sink Current/Pin	120 mA
Maximum Power Dissipation	0.5 watts
T _{STG} Storage Temperature	-65° to +150°C

Note: Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to this device resulting in functional or reliability type failures.

CAPACITANCE

$T_A = 25^\circ\text{C}$, $f = 1$ MHz, $V_{IN} = 0\text{V}$, $V_{OUT} = 0\text{V}$

Pins	SOIC	QSOP	PDIP	ZIP	Unit
1-7, 9, 10	4	4	5	7	pF
11 - 15	6	6	7	9	pF
—	8	8	9	10	pF

Note: Capacitance is characterized but not tested.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾	Min	Max	Unit
I_{CC}	Quiescent Power Supply Current	$V_{CC} = \text{Max.}$, $\text{freq} = 0$ $0\text{V} \leq V_{IN} \leq 0.2\text{V}$ or $V_{CC}-0.2\text{V} \leq V_{IN} \leq V_{CC}$	—	1.5	mA
ΔI_{CC}	Supply Current per Input @ TTL HIGH	$V_{CC} = \text{Max.}$, $V_{IN} = 3.4\text{V}$, $\text{freq} = 0$ ⁽²⁾	—	2.0	mA
Q_{CCD}	Supply Current per Input per MHz	$V_{CC} = \text{Max.}$, Outputs Open and Enabled One Bit Toggling @ 50% Duty Cycle Other Inputs at GND or V_{CC} ^(3,4)	—	0.25	mA/ MHz

Notes:

- For conditions shown as Min. or Max., use the appropriate values specified under DC specifications.
- Per TTL driven input ($V_{IN} = 3.4\text{V}$).
- For flip-flops, Q_{CCD} is measured by switching one of the data input pins so that the output changes every clock cycle. This is a measurement of device power consumption only and does not include power to drive load capacitance or tester capacitance. This parameter is guaranteed by design but not tested.
- I_C can be computed using the above parameters as explained in the Technical Overview section.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Commercial $T_A = 0^\circ\text{C}$ to 70°C , $V_{CC} = 5.0\text{V} \pm 5\%$

Military $T_A = -55^\circ\text{C}$ to 125°C , $V_{CC} = 5.0\text{V} \pm 10\%$

Symbol	Parameter	Test Conditions	Min	Typ ⁽¹⁾	Max	Unit
V_{IH}	Input HIGH Voltage	Logic HIGH for All Inputs	2.0	—	—	V
V_{IL}	Input LOW Voltage	Logic LOW for All Inputs	—	—	0.8	V
ΔV_T	Input Hysteresis	$V_{TLH} - V_{THL}$ for All Inputs	—	0.2	—	V
$ I_{IH} $ $ I_{IL} $	Input Current Input HIGH or LOW	$V_{CC} = \text{Max.}, 0 \leq V_{IN} < V_{CC}$	—	—	5	μA
I_{OS}	Short Circuit Current (FCTXXX)	$V_{CC} = \text{Max.}, V_{OUT} = \text{GND}^{(2,3)}$	-60	—	—	mA
I_{OR}	Current Drive (FCT2XXX)	$V_{CC} = \text{Max.}, V_{OUT} = 2.0\text{V}^{(3)}$	50	—	—	mA
V_{IC}	Input Clamp Voltage	$V_{CC} = \text{Min.}, I_{IN} = -18\text{ mA}, T_A = 25^\circ\text{C}^{(3)}$	—	-0.7	-1.2	V
V_{OH}	Output HIGH Voltage	$V_{CC} = \text{Min.}, I_{OH} = -12\text{ mA (MIL)}$ $I_{OH} = -15\text{ mA (COM)}$	2.4 2.4	— —	— —	V
V_{OL}	Output LOW Voltage (FCTXXX)	$V_{CC} = \text{Min.}, I_{OL} = 32\text{ mA (MIL)}$ $I_{OL} = 48\text{ mA (COM)}$	— —	— —	0.50 0.50	V
V_{OL}	Output LOW Voltage (FCT2XXX- 25 Ω)	$V_{CC} = \text{Min.}, I_{OL} = 12\text{ mA (MIL)}$ $I_{OL} = 12\text{ mA (COM)}$	— —	— —	0.50 0.50	V
R_{OUT}	Output Resistance (FCT2XXX- 25 Ω)	$V_{CC} = \text{Min.}, I_{OL} = 12\text{ mA (MIL)}$ $I_{OL} = 12\text{ mA (COM)}$	— 20	25 28	— 40	Ω

Notes:

- Typical values indicate $V_{CC} = 5.0\text{V}$ and $T_A = 25^\circ\text{C}$.
- Not more than one output should be shorted and the duration is ≤ 1 second.
- These parameters are guaranteed by design but not tested.

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

Commercial T_A = 0°C to 70°C, V_{CC} = 5.0V ± 5%

Military T_A = -55°C to 125°C, V_{CC} = 5.0V ± 10%

C_{LOAD} = 50 pF, R_{LOAD} = 500Ω unless otherwise noted.

Symbol	Description ⁽¹⁾		161 163 2161 2163		161A 163A 2161A 2163A		161C 163C		Unit
			Min	Max	Min	Max	Min	Max	
t _{CPQ}	Propagation Delay CP TO Q _i , 161/3	Com	2.0	9.5	2.0	6.2	2.0	5.6	ns
		Mil	2.0	10	2.0	6.5	2.0	6.1	
t _{CPQ}	Propagation Delay CP to Q _i , 2161/3	Com	2.0	9.5	2.0	6.2	—	—	ns
		Mil	2.0	10	2.0	6.5	—	—	
t _{MRQ}	Propagation Delay $\overline{\text{MR}}$ to Q _i , 161	Com	2.0	13	2.0	8.5	2.0	7.8	ns
		Mil	2.0	14	2.0	9.1	2.0	8.3	
t _{MRQ}	Propagation Delay $\overline{\text{MR}}$ to Q _i , 2161	Com	2.0	14	2.0	9.1	—	—	ns
		Mil	2.0	13	2.0	8.5	—	—	
t _{CPTC}	Propagation Delay CP to TC	Com	2.0	15	2.0	9.8	2.0	8.8	ns
		Mil	2.0	16.5	2.0	10.8	2.0	9.8	
t _{CETC}	Propagation Delay CET to TC	Com	1.5	8.5	1.5	5.5	1.5	5.0	ns
		Mil	1.5	9	1.5	5.9	1.5	5.4	
t _{MRTC}	Propagation Delay $\overline{\text{MR}}$ to TC	Com	1.5	11.5	1.5	7.5	1.5	6.8	ns
		Mil	1.5	12.5	1.5	8.2	1.5	7.4	

Notes:

1. Minimums guaranteed but not tested.
2. This parameter is guaranteed by design but not tested.
3. See Test Circuit and Waveforms.

TIMING REQUIREMENTS OVER OPERATING RANGE

Commercial T_A = 0°C to 70°C, V_{CC} = 5.0V ± 5%

Military T_A = -55°C to 125°C, V_{CC} = 5.0V ± 10%

C_{LOAD} = 50 pF, R_{LOAD} = 500Ω unless otherwise noted.

Symbol	Description		161 163 2161 2163		161A 163A 2161A 2163A		161C 163C		Unit
			Min	Max	Min	Max	Min	Max	
t _s	Data Setup Time D _i to CP	Com	5.0		4.0		3.5		ns
		Mil	5.5		4.5		4.0		
t _h	Data Hold Time D _i to CP	Com	1.5		1.5		1.5		ns
		Mil	2.0		2.0		2.0		
t _{cs}	Count Enab. Setup Time CEP, CET to CP	Com	11.5		9.5		8.5		ns
		Mil	13		11		10		
t _{ch}	Count Enable Hold Time CEP, CET to CP	Com	0		0		0		ns
		Mil	0		0		0		
t _{MRS} t _{PES}	Control Setup Time \overline{MR} , \overline{PE} to CP	Com	11.5		9.5		8.5		ns
		Mil	13.5		11.5		10.5		
t _{MRH} t _{PEH}	Control Hold Time \overline{MR} , \overline{PE} to CP	Com	1.5		1.5		1.5		ns
		Mil	1.5		1.5		1.5		
t _{CPW}	Clock Pulse Width ⁽¹⁾ HIGH or LOW	Com	5.0		4.0		3.0		ns
		Mil	5.0		4.0		3.0		
t _{MRW}	\overline{MR} Reset Pulse Width ⁽¹⁾ 161, 2161	Com	5.0		4.0		3.0		ns
		Mil	5.0		4.0		3.0		
t _{MRW}	Reset Recovery Time ⁽¹⁾ \overline{MR} to CP, 161, 2161	Com	6.0		5.0		4.0		ns
		Mil	6.0		5.0		4.0		

Notes:

1. This parameter is guaranteed by design but not tested.
2. See Test Circuit and Waveforms.